



40V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

| V _{(BR)DSS} | R _{DS(ON)} | I _D T _C = +25°C |
|----------------------|------------------------------|--|
| 40V | 24mΩ @V _{GS} = 10V | 28A |
| 40 V | 32mΩ @V _{GS} = 4.5V | 24A |

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(ON)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Backlighting
- DC-DC Converters
- · Power Management Functions

Features

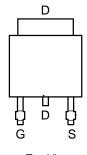
- 100% Unclamped Inductive Switch (UIS) Test in Production
- Low On-resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

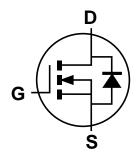
- Case: TO252
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Matte Tin Finish Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.33 grams (Approximate)







Top View Pin-Out



Equivalent Circuit

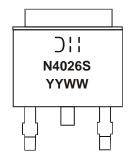
Ordering Information (Note 4)

| _ | | | |
|---|---------------|-------|-------------------|
| | Product | Case | Packaging |
| | DMN4026SK3-13 | TO252 | 2.500/Tape & Reel |

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



Oll = Manufacturer's Marking
N4026S = Product Type Marking Code
YYWW = Date Code Marking
YY = Year (ex: 15 = 2015)
WW = Week (01 to 53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

| Characteristic | | | Symbol | Value | Unit |
|---|----------------|----------|-----------------|-------|------|
| Drain-Source Voltage | | | V_{DSS} | 40 | V |
| Gate-Source Voltage | | | V_{GSS} | ±20 | V |
| Continuous Drain Current (Note 6) V _{GS} = 10V | I _D | 28 18 | А | | |
| Maximum Body Diode Continuous Current | | | I _S | 2.5 | Α |
| Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%) | | | I _{DM} | 70 | Α |
| Avalanche Current (Note 7) L = 0.1mH | | | I _{AS} | 18 | Α |
| Avalanche Energy (Note 7) L = 0.1mH | | | Eas | 17 | mJ |

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

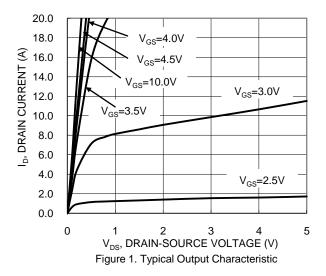
| Characteristic | Symbol | Value | Unit | |
|--|------------------------|----------------------------------|-------------|------|
| Total Dawar Dissination (Note 5) | T _A = +25°C | | 1.6 | W |
| Total Power Dissipation (Note 5) | $T_A = +70^{\circ}C$ | P_{D} | 1.0 | |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady state | D | 75 | °C/W |
| Thermal Resistance, Junction to Ambient (Note 3) | t<10s | $R_{\theta JA}$ | 32.7 | |
| Total Power Dissipation (Note 6) | T _A = +25°C | Ъ | 3.4 | W |
| Total Power Dissipation (Note 6) | $T_A = +70^{\circ}C$ | P_{D} | 2.1 | |
| Thermal Resistance, Junction to Ambient (Note 6) | Steady state | D | 37 | °C/W |
| Thermal Resistance, Junction to Ambient (Note o) | t<10s | $R_{\theta JA}$ | 18.1 | |
| Thermal Resistance, Junction to Case (Note 6) | | R ₀ JC | 4.5 | |
| Operating and Storage Temperature Range | | T _{J,} T _{STG} | -55 to +150 | °C |

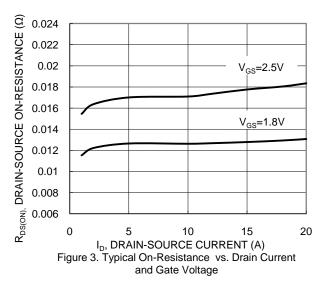
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition | |
|--|---------------------|-----|------|------|-------|--|--|
| OFF CHARACTERISTICS (Note 8) | | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | 40 | _ | _ | V | $V_{GS} = 0V, I_{D} = 250\mu A$ | |
| Zero Gate Voltage Drain Current | I _{DSS} | _ | _ | 1 | μΑ | $V_{DS} = 40V, V_{GS} = 0V$ | |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±100 | nA | $V_{GS} = \pm 20V, V_{DS} = 0V$ | |
| ON CHARACTERISTICS (Note 8) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | 1 | _ | 3 | V | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | |
| Static Drain-Source On-Resistance | | _ | 15 | 24 | mΩ | $V_{GS} = 10V, I_D = 6A$ | |
| Static Drain-Source On-Resistance | R _{DS(ON)} | _ | 20 | 32 | 11177 | V _{GS} = 4.5V, I _D = 5A | |
| Diode Forward Voltage | V _{SD} | _ | 0.7 | 1.0 | V | V _{GS} = 0V, I _S = 1.0A | |
| DYNAMIC CHARACTERISTICS (Note 9) | | | | | | | |
| Input Capacitance | Ciss | | 1181 | _ | | $V_{DS} = 20V, V_{GS} = 0V,$ f = 1.0MHz | |
| Output Capacitance | Coss | _ | 85 | _ | pF | | |
| Reverse Transfer Capacitance | Crss | _ | 63 | _ | | | |
| Gate Resistance | Rg | _ | 1.5 | _ | Ω | $V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1.0MHz$ | |
| Total Gate Charge (V _{GS} = 4.5V) | Q_g | _ | 9.6 | _ | | | |
| Total Gate Charge (V _{GS} = 10V) | Qg | _ | 21.3 | _ | nC | V _{DS} = 20V, I _D = 8A | |
| Gate-Source Charge | Q_{gs} | _ | 3.7 | _ | IIC | | |
| Gate-Drain Charge | Q_{gd} | _ | 3.0 | _ | | | |
| Turn-On Delay Time | t _{D(ON)} | _ | 4.3 | _ | | $V_{DD} = 25V, R_{L} = 2.5\Omega$ | |
| Turn-On Rise Time | t _R | _ | 4.6 | _ | | | |
| Turn-Off Delay Time | t _{D(OFF)} | _ | 19.5 | _ | ns | $V_{GS} = 10V, R_G = 3\Omega$ | |
| Turn-Off Fall Time | t _F | _ | 3.1 | _ | | | |
| Body Diode Reverse Recovery Time | t _{RR} | _ | 12.0 | _ | ns | I _F = 8A, di/dt = 100A/μs | |
| Body Diode Reverse Recovery Charge | Q _{RR} | _ | 3.85 | _ | nC | I _F = 8A, di/dt = 100A/μs | |

- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_J = +25°C.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.







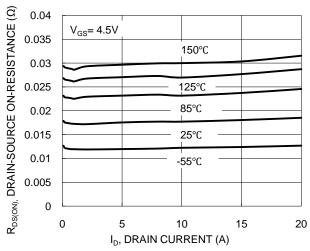
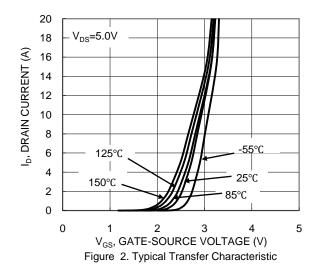
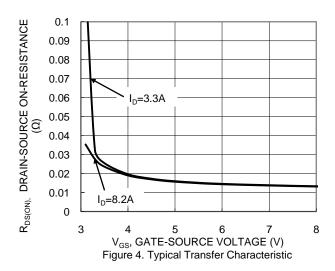


Figure 5. Typical On-Resistance vs. Drain Current and Temperature





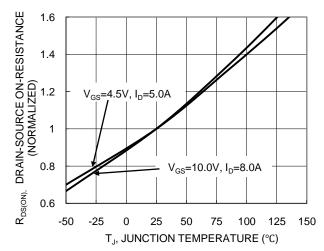


Figure 6. On-Resistance Variation with Temperature



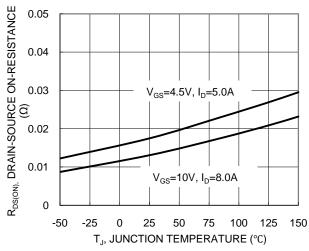
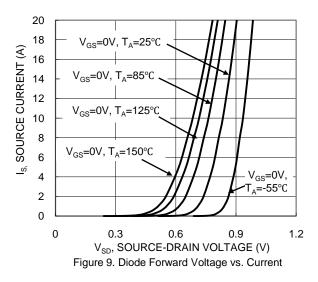
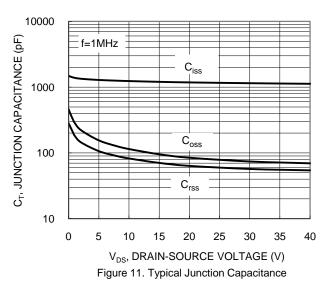


Figure 7. On-Resistance Variation with Temperature





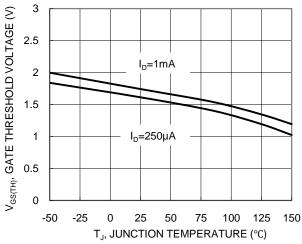


Figure 8. Gate Threshold Variation vs. Junction Temperature

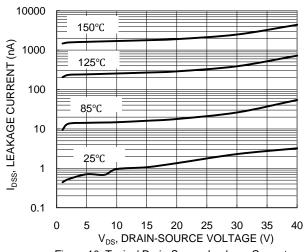
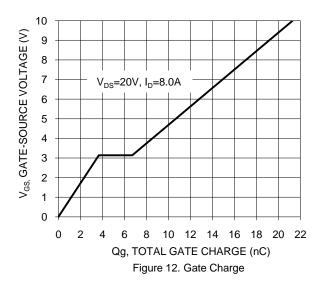


Figure 10. Typical Drain-Source Leakage Current vs. Voltage





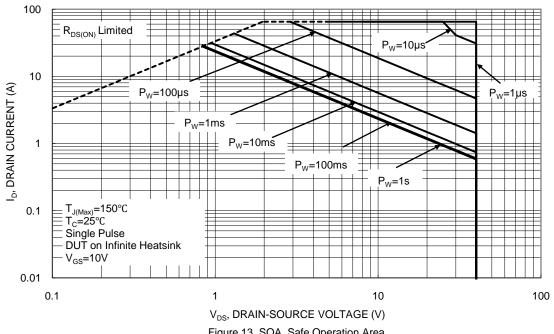
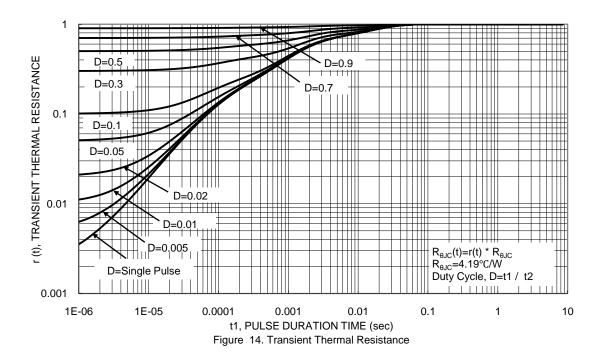


Figure 13. SOA, Safe Operation Area

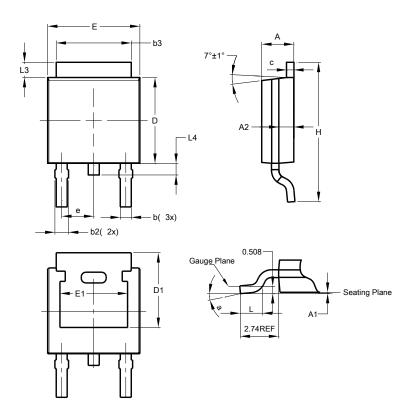


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Package Outline Dimensions

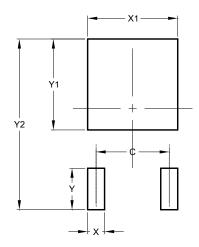
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



| TO252 (DPAK) | | | | | |
|----------------------|------|-------|-------|--|--|
| Dim | Min | Max | Тур | | |
| Α | 2.19 | 2.39 | 2.29 | | |
| A1 | 0.00 | 0.13 | 0.08 | | |
| A2 | 0.97 | 1.17 | 1.07 | | |
| b | 0.64 | 0.88 | 0.783 | | |
| b2 | 0.76 | 1.14 | 0.95 | | |
| b3 | 5.21 | 5.46 | 5.33 | | |
| С | 0.45 | 0.58 | 0.531 | | |
| D | 6.00 | 6.20 | 6.10 | | |
| D1 | 5.21 | - | - | | |
| е | - | - | 2.286 | | |
| Е | 6.45 | 6.70 | 6.58 | | |
| E1 | 4.32 | - | - | | |
| Н | 9.40 | 10.41 | 9.91 | | |
| L | 1.40 | 1.78 | 1.59 | | |
| L3 | 0.88 | 1.27 | 1.08 | | |
| L4 | 0.64 | 1.02 | 0.83 | | |
| а | 0° | 10° | | | |
| All Dimensions in mm | | | | | |

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



| Dimensions | Value (in mm) | | |
|------------|---------------|--|--|
| С | 4.572 | | |
| X | 1.060 | | |
| X1 | 5.632 | | |
| Y | 2.600 | | |
| Y1 | 5.700 | | |
| Y2 | 10.700 | | |



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